

## A circular dielectric grating for vertical extraction of single quantum dot emission

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We demonstrate a nanostructure composed of partially etched annular trenches in a suspended GaAs membrane, designed for efficient and moderately broadband ( $\approx 5$  nm) emission extraction from single InAs quantum dots. Simulations indicate that a dipole embedded in the nanostructure center radiates upward into free space with a nearly Gaussian far field, allowing a collection efficiency  $>80\%$  with a high numerical aperture ( $\text{NA} = 0.7$ ) optic and with  $\approx 12\times$  Purcell radiative rate enhancement. Fabricated devices exhibit a  $\approx 10\%$  photon collection efficiency with a  $\text{NA} = 0.42$  objective, a  $20\times$  improvement over quantum dots in unpatterned GaAs. A fourfold exciton lifetime reduction indicates moderate Purcell enhancement. © 2011 American Institute of Physics. [doi:10.1063/1.3615051]

Efficient extraction of single photons emitted by individual semiconductor epitaxial quantum dots (QDs) is a necessity for many applications in spectroscopy and classical and quantum information processing.<sup>1</sup> As epitaxially grown QDs are embedded in semiconductor material, total internal reflection of the emitted light at the semiconductor-air interface and radiation divergence can typically lead to  $<1\%$  collection efficiencies even with high numerical aperture (NA) optics. Photonic structures such as micropillar cavities can provide both QD radiative rate Purcell enhancement and a far-field radiation pattern that can be effectively collected,<sup>2</sup> but require precise spectral tuning of the cavity resonance to the QD emission line. In contrast, vertically oriented etched nanowires<sup>3</sup> are spectrally broadband structures that have recently been shown to provide large free space collection efficiencies, albeit without Purcell enhancement and with an involved fabrication process. Broadband operation not only relaxes the spectral alignment requirement, which may impose strict constraints in fabrication tolerances, but also is a necessity in spectroscopic applications in which simultaneous detection of various spectrally separate transitions is desired. Here, we present an approach for efficient free space extraction of QD emission using a suspended circular grating. This structure requires a simple nanofabrication procedure and supports a relatively broad (few nanometer) optical resonance with a directional, nearly Gaussian far-field, which allows efficient free space photon collection. Simulations predict a collection efficiency of  $\approx 53\%$  ( $80\%$ ) into a  $\text{NA} = 0.42$  ( $0.7$ ) optic. In fabricated devices, we report a  $\approx 10\%$  single QD photoluminescence (PL) collection efficiency into a  $\text{NA} = 0.42$  objective, a  $\approx 20\times$  improvement compared to QDs in unpatterned bulk GaAs. A fourfold reduction in QD lifetime is also observed, indicating moderate radiative rate enhancement.

Our nanostructure (Fig. 1) consists of a circular dielectric grating with radial period  $\Lambda$  that surrounds a central circular

region of radius  $2\Lambda$ , produced on a suspended GaAs slab of thickness  $t = 190$  nm. The GaAs slab supports single TE and TM polarized modes (electric or magnetic field parallel to the slab, respectively). The grating is composed of ten partially etched circular trenches of width  $w$  and depth  $d$ , with  $t/2 < d < t$ . Quantum dots are grown at half the GaAs slab thickness ( $z = 0$ ) and located randomly in the  $xy$  plane. This “bullseye” geometry favors extraction of emission from QDs in the central circular region. It is based on (linear) high-contrast second-order Bragg gratings recently introduced<sup>4</sup> for light extraction from planar waveguides. While similar circular geometries have been employed for enhanced light extraction from light emitting diodes,<sup>5</sup> and for demonstrating annular Bragg lasers,<sup>6</sup> here we show an application in QD single photon extraction.

The design process consisted of a series of finite difference time domain simulations that maximized vertical light extraction near the expected QD  $s$ -shell emission ( $\lambda_{\text{QD}} \approx 940$  nm), by varying  $\Lambda$ ,  $t$ , and  $w$ . The structures were excited with a horizontally oriented electric dipole at the bullseye center ( $x = 0$ ,  $y = 0$ ), representing an optimally placed QD. Total radiated power, steady-state upwards emission, and electromagnetic

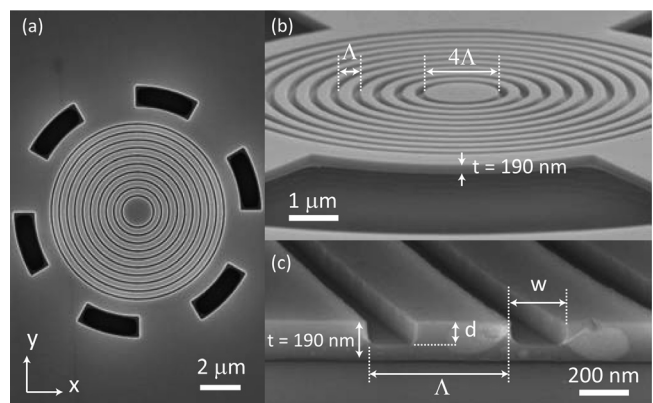


FIG. 1. (a) Top, (b) angled, and (c) cross-sectional SEM images of suspended circular dielectric grating structure.

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fields were then recorded at several wavelengths. The grating period  $\Lambda$  was initially chosen to satisfy the second-order Bragg condition,  $\Lambda = \lambda_{QD}/n_{TE}$ , to allow for efficient vertical light extraction ( $n_{TE}$  is the GaAs slab TE mode effective index). The dipole orientation was assumed to be aligned along the  $xy$  plane, exciting only TE slab waves. Starting values for trench width and depth were  $w = 100$  nm and  $d = 0.5t$ , deemed to be easily fabricated. Vertical light scattering at the gratings is partial, so that second-order Bragg reflections towards the center lead to vertically leaky cavity resonances as shown in Figs. 2(a) and 2(b). The large index contrast at the trenches leads to strong reflections and out-of-slab-plane scattering at the semiconductor-air interfaces, evident in the strong field concentration at the bullseye center in Fig. 2(a) and the fast field decay within the first couple of trenches from the center (Fig. 2(b)). Large differences in propagation constants in the semiconductor and air produce significant resonance spectral shifts with small variations in trench width. Trench depth ( $d$ ) has a strong influence on the quality factor ( $Q$ ) and vertical light extraction, as incomplete spatial overlap between a trench and an incident slab-bound wave leads to both coupling to radiating waves and lower modal reflectivity. Preferential upwards vertical extraction results from the grating asymmetry and is optimized through the trench depth.<sup>7</sup> We note that in addition to the mode shown in Fig. 1, the cavity supports additional resonances that can be excited by dipoles offset from the bullseye center. Coupling to these resonances can lead to modified spontaneous emission rates and collection efficiencies.<sup>7</sup>

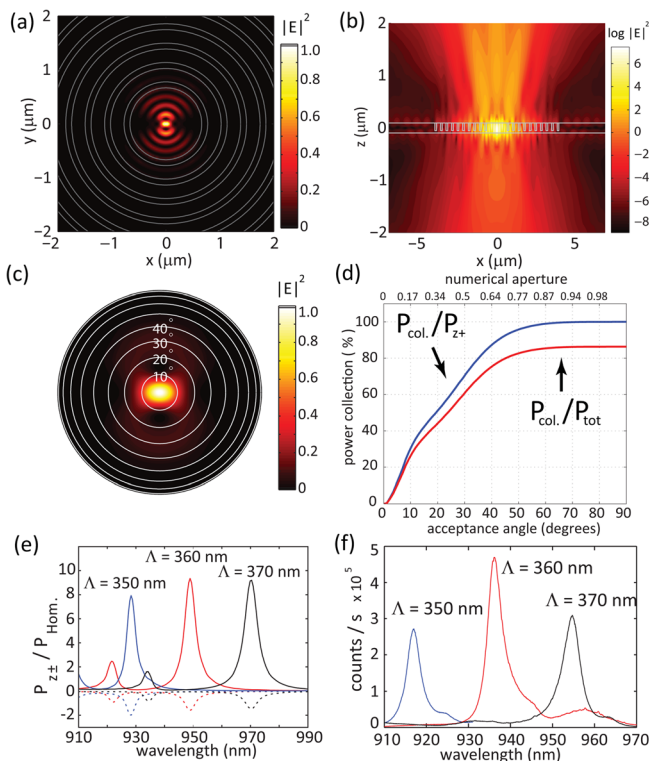


FIG. 2. (Color online) Electric field intensity in the (a)  $xy$  and (b)  $xz$  planes (log scale). (c) Far-field polar plot for the cavity mode with  $\Lambda = 360$  nm. (d) Collected power ( $P_{col}$ ) as a function of varying NA, normalized by the upwards ( $P_{z+}$ ) and total ( $P_{tot}$ ) emitted powers. (e) Calculated vertically extracted power as a function of wavelength, normalized to the homogeneous medium electric dipole power  $P_{Hom}$  for  $d = 0.70t$ . Continuous lines: upwards ( $+z$ ) extraction; dotted: downwards ( $-z$ ). (f) Experimental PL spectra for high QD density devices.

Figure 2(e) shows simulated, upwards (continuous) and downwards (dotted) vertically extracted power as a function of wavelength for structures with  $\Lambda = 350$  nm, 360 nm, and 370 nm,  $w = 110$  nm, and  $d \approx 0.70t$ . All curves are normalized to the homogeneous medium electric dipole power,  $P_{Hom}$ . Trench parameters reflect a trade-off in cavity  $Q$  and vertical light extraction, as discussed above. It is apparent that for each  $\Lambda$ , an  $\sim 5$  nm wide resonance exists, with preferential upwards ( $+z$ ) light extraction. The upwards extracted power is  $\approx 10 \times P_{Hom}$ , an indication of Purcell radiation rate enhancement due to the cavity.<sup>8</sup> Indeed, for the  $\Lambda = 360$  nm structure, on which we now focus, the enhancement  $F_p$  at the maximum extraction wavelength ( $\lambda_c = 948.9$  nm) is  $F_p = P_{tot}/P_{Hom} = 11.0$ , where  $P_{tot}$  is the total radiated power in all directions. This resonance has  $Q = 200$ , and its effective mode volume, calculated from the field distribution, is  $V_{eff} = 1.29(\lambda_c/n)^3$  ( $n$  is the GaAs refractive index).<sup>7</sup> The value for  $F_p$  predicted by  $Q$  and  $V_{eff}$  is  $\approx 11.8$  and is consistent with the value determined above by the dipole radiation simulations. Note that, given the modal field distribution in Fig. 2(a), the modified emission rate depends strongly on its spatial location, being maximal at the bullseye center.

The steady-state fields at a surface just above the GaAs slab were used to calculate the far-field pattern in Fig. 2(c), which shows that the emission is nearly Gaussian with a small divergence angle. To better quantify this, we calculate the power  $P_{col}$  collected by an optic of varying NA. Figure 2(d) shows the fractions of the upwards emitted ( $P_{z+}$ ) and total ( $P_{tot}$ ) powers collected as a function of the collection optic acceptance angle. For  $NA = 0.42$  ( $24.8^\circ$  acceptance angle),  $\approx 60\%$  of the upwards emitted power (or  $\approx 53\%$  of the total emission) can be collected. For  $NA > 0.7$ , or an acceptance angle  $> 44.4^\circ$ , collection superior to 80% of the total emission can be achieved. We note that our suspended grating approach limits radiation into the substrate without the need to oxidize the AlGaAs, bond the grating to a low index layer,<sup>6</sup> or utilize a deeply etched geometry.<sup>2,3</sup>

Gratings were fabricated in a  $t = 190$  nm GaAs layer containing a single layer of InAs QDs (density gradient from  $> 100 \mu\text{m}^{-2}$  to  $0 \mu\text{m}^{-2}$  along the  $(01\bar{1})$  direction) on top of a  $1 \mu\text{m}$  thick  $\text{Al}_{0.6}\text{Ga}_{0.4}\text{As}$  sacrificial layer.<sup>7</sup> Fabrication steps included electron-beam lithography, plasma dry etching, and wet chemical etching. The plasma dry etch was optimized so that the GaAs would be partially etched to a desired depth in the grating region (Fig. 1(b)) and fully etched over the curved rectangles just outside the grating region (Fig. 1(a)), which were used in the wet etching step to undercut and suspend the device.

Testing was done in a liquid He flow cryostat at  $\approx 8$  K. Figure 2(f) shows PL spectra of three devices with a high QD density and  $\Lambda = 350$  nm, 360 nm, and 370 nm and  $d/t > 0.7$ , for pulsed pumping at a 780 nm wavelength (above the GaAs bandgap). The spectra closely resemble the theoretical curves of Fig. 2(e), with three,  $\approx 5$  nm wide peaks spaced by  $\approx 20$  nm. Deviations are likely due to differences in geometry and refractive index between simulated and fabricated structures. These results validated our simulations and served to calibrate the fabrication process. Figure 3(a) shows PL spectra at various pump powers for a device with  $\Lambda = 360$  nm, now produced in a low QD density region of the sample. Three

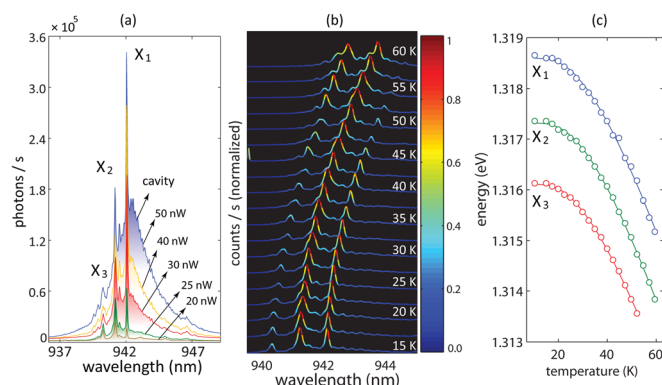


FIG. 3. (Color online) (a) PL spectrum from a low QD density  $\Lambda = 360$  nm device, for various pump powers. (b) Temperature evolution of spectrum in (a) (25 nW pump). (c) Temperature evolution of excitonic energies. Continuous lines are fits.

isolated exciton lines are observed on top of a broad background near 942 nm. The sharp lines red-shift with increasing temperature (Fig. 3(b)) with a dependence that can be fit to a model that predicts a red-shift of the InAs bandgap (Fig. 3(c)).<sup>7,9,10</sup> In contrast, the broad background observed in Fig. 3(a) shifts more slowly with temperature and likely originates from out-coupling of broad QD multiexcitonic emission via the leaky cavity mode.<sup>11</sup> This is reinforced by the observation, in Fig. 3(b), that the sharp QD lines are maximized in the wavelength range  $940 \text{ nm} < \lambda < 942 \text{ nm}$ , when aligned to the broad cavity peak and decrease when driven away from it. The slower cavity mode shift with temperature corresponds to a shift in refractive index.<sup>12</sup>

Figure 4(a) shows the detected PL as a function of average pump power for the excitonic lines  $X_1$  and  $X_2$  and the cavity mode emission from Fig. 3(a). While  $X_1$  and  $X_2$  saturate at  $\approx 20$  nW, the cavity emission increases past this level. This further supports our assignments of QD transitions and cavity mode in the Fig. 3(a) spectra. Saturated photon rates (collected with a  $\text{NA} = 0.42$  objective) from  $X_1$  and  $X_2$  were at least 20 times higher than from typical QDs embedded in unpatterned GaAs, as shown in Fig. 4(a). Assuming 100% QD quantum efficiency, we estimate a collection efficiency of  $\approx 10\%$  is achieved with the bullseye pattern.<sup>7</sup> A lifetime measurement of  $X_1$  after a  $\approx 300$  pm bandpass filter (Fig. 4(b)) exhibits a multi-exponential decay with a fast lifetime of  $\approx 360$  ps, limited by the  $\approx 600$  ps timing jitter of the detec-

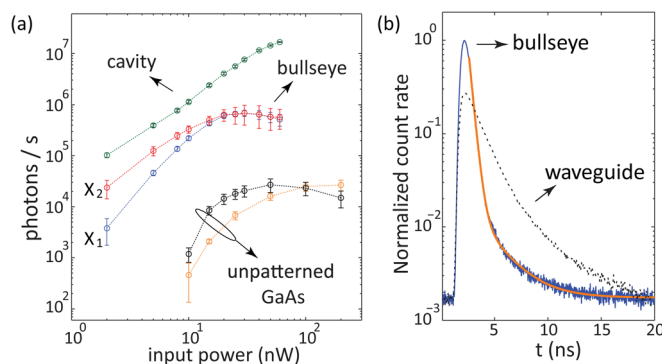


FIG. 4. (Color online) (a) PL as a function of pump power for  $X_1$ ,  $X_2$ , and cavity emission from Fig. 3(a), and two QDs in unpatterned GaAs. Error bars are 95% fit confidence intervals. (b) Solid:  $X_1$  lifetime trace with fit. Dotted: lifetime trace for QD embedded in a suspended GaAs waveguide.

tors. For comparison, the lifetime of a single QD inside of a suspended GaAs waveguide<sup>13</sup> (dotted in Fig. 4(b)), for which no radiative rate modification is expected, was  $\approx 1.5$  ns. This suggests  $F_p > 4$ . Note that since the pump in Fig. 4(a) is pulsed with a 20 ns repetition period, significantly longer than the lifetime, the increase in detected counts relative to unpatterned GaAs is solely due to enhanced photon extraction and collection into the objective.

Improved photon extraction efficiency can potentially be achieved with a higher NA collection optic (50% increase for  $\text{NA} = 0.7$ ) and fabrication control,<sup>7</sup> while deterministic QD spatial alignment<sup>14,15</sup> can enhance both the efficiency and Purcell factor. Although single-photon emission from the bullseye is accompanied by undesirable cavity emission, a few devices exhibited considerably less cavity mode feeding, albeit with lesser extraction efficiencies. Since enhanced extraction efficiency is due to the directional far-field pattern, a trade-off may be achieved between Purcell enhancement and cavity feeding for reduced  $Q$ . It is also likely that quasi-resonant QD pumping will lead to reduced cavity feeding.<sup>16</sup> These possibilities are under investigation.

In summary, we developed a nanophotonic circular grating that provides  $\approx 10\%$  free space collection efficiencies for single InAs QD photons within a wavelength range of  $\approx 5$  nm. Lifetime reduction of at least a factor of four is achieved, which, taken together with the enhanced collection efficiency, indicates Purcell rate enhancement. This structure allows for efficient and broadband spectroscopy of single QDs, and has potential for use as a bright single-photon source.

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